Search Notes				
		 		

Application/Control No.	Applicant(s)/Patent Reexamination
10/749,190	LEE, BYOUNG-GO

2618

Examiner

Perez M. Angelica

Applicant(s)/Patent under Reexamination LEE, BYOUNG-GON Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
4 55	575.4,505. 1,575.1,57 5.8	9/28/2006	A.P.	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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